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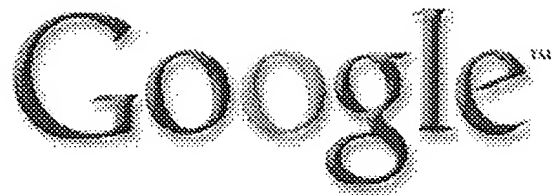Google Search | I'm Feeling Lucky

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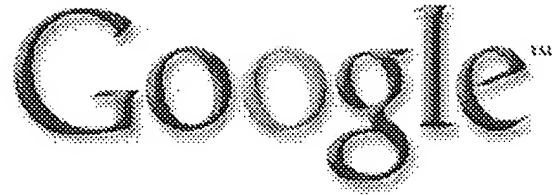
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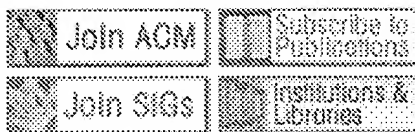Journal of the ACM (JACM)
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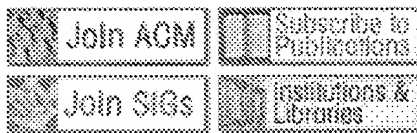
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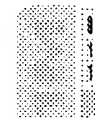Pilot program to create full-text interpublisher searchability.

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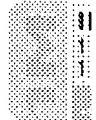
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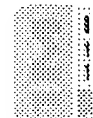
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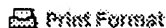○ Conference Proceedings
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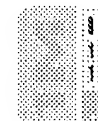
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